

# IGBT Chip in NPT-technology

#### **FEATURES:**

- 1200V NPT technology
- 180µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

# This chip is used for:

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## Applications:

drives, SMPS, resonant applications

Chip Type	V <sub>CE</sub>	Icn	Die Size	Package	Ordering Code
SIGC25T120CS	1200V	15A	5.71 x 4.53 mm <sup>2</sup>	sawn on foil	Q67050-A4114

# **MECHANICAL PARAMETER:**

Raster size	5.71 x 4.53	mm <sup>2</sup>		
Emitter pad size	2 x (2.18 x 1.6)			
Gate pad size	1.09 x 0.68			
Area total / active	25.9 / 18.7			
Thickness	180	μm		
Wafer size	150	mm		
Flat position	270	grd		
Max.possible chips per wafer	555 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



## **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	45	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# STATIC CHARACTERISTICS (tested on chip), $T_{j}$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions		Value			Unit
Tarameter	Cymbol	Conditions	min.	typ.	max.	Omi
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V , I <sub>C</sub> =1mA	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =15A	2.5	3.0	3.6	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C$ =0.6mA , $V_{GE}$ = $V_{CE}$	3.0	4.0	5.0	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			2	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			480	nA

# **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiailletei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	1250		pF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	100		
Reverse transfer capacitance	Crss	f=1MHz	-	65		

## SWITCHING CHARACTERISTICS (tested at component), Inductive Load

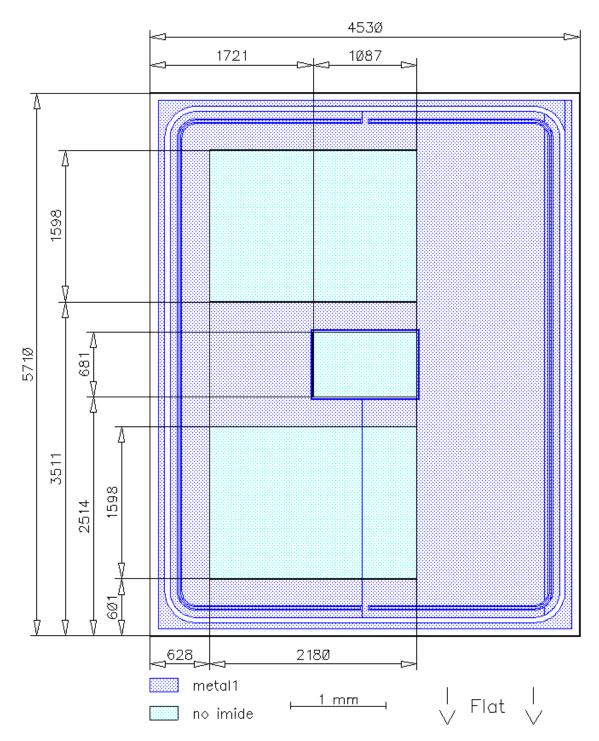
Parameter	Symbol	Conditions 1)	Value			Unit
r arameter	Symbol	Conditions	min.	typ.	max.	Oiiit
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =150°C	-	38		ns
Rise time	$t_{r}$	V <sub>CC</sub> =800V, I <sub>C</sub> =15A, V <sub>GE</sub> =-15/15V,	-	30		
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = -15/15 \text{V},$	-	652		
Fall time	$t_{f}$	$R_{\rm G}$ = 33 $\Omega$	-	31		

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



## **CHIP DRAWING:**

Die-Size 4530 um x 5710 um





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet		SGP15N120					
DESCRIPTION:							
AQL 0,65 for visual inspection according to failure catalog							
Electrostatic Discharge Sensitive Device according to MIL-STD 883							
Test-Normen Villach/Prüffeld							

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